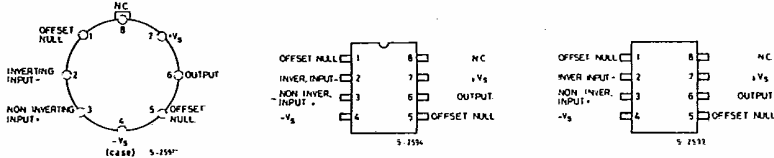




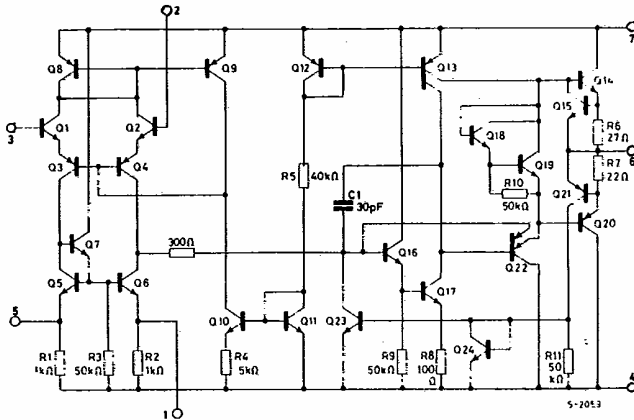
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CONNECTION DIAGRAMS AND ORDERING NUMBERS



| Type     | TO-99      | Minidip   | SO-8       |
|----------|------------|-----------|------------|
| LS 141   | LS 141 TB  | —         | —          |
| LS 141A  | LS 141 ATB | —         | —          |
| LS 141C  | LS 141 CTB | LS 141 CB | LS 141 CM  |
| LS 8141  | —          | —         | LS 8141M   |
| LS 8141A | —          | —         | LS 8141 AM |
| LS 8141C | —          | —         | LS 8141 CM |

SCHEMATIC DIAGRAM



THERMAL DATA

|   | TO-99    | Minidip  | SO-8      |
|---|----------|----------|-----------|
| $R_{th(j-amb)}$ Thermal resistance junction ambient max | 155 °C/W | 120 °C/W | 200* °C/W |

\* Measured with the device mounted on a ceramic substrate (25 x 16 x 0.6 mm)

0259 E-02



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ELECTRICAL CHARACTERISTICS (see note)

| Parameter   | Test conditions  | LS 141     |            |      | LS 141A    |            |          | LS 141C    |            |      | Unit                     |
|---|--|------------|------------|------|------------|------------|----------|------------|------------|------|--------------------------|
|   |  | Min.       | Typ.       | Max. | Min.       | Typ.       | Max.     | Min.       | Typ.       | Max. |                          |
| V <sub>os</sub> Input offset voltage                                | T <sub>amb</sub> = 25°C<br>R <sub>g</sub> ≤ 10 kΩ<br>R <sub>g</sub> ≤ 50 Ω   |            | 1          | 5    |            | 0.8        | 3        |            | 2          | 6    | mV<br>mV                 |
|   | T <sub>amb</sub> = T <sub>min</sub> to T <sub>max</sub><br>R <sub>g</sub> ≤ 10 kΩ<br>R <sub>g</sub> ≤ 50 Ω   |            |            | 6    |            |            | 4        |            |            | 7.5  | mV<br>mV                 |
| ΔV <sub>os</sub> Input offset voltage adjust. range                 | V <sub>s</sub> = ±20V  |            |            |      | ±10        |            |          |            |            |      | mV                       |
|   | V <sub>s</sub> = ±15V T <sub>amb</sub> = 25°C  |            | ±15        |      |            |            |          |            | ±15        |      | mV                       |
| $\frac{\Delta V_{os}}{\Delta T}$ Average input offset voltage drift |  |            |            |      |            |            | 15       |            |            |      | $\frac{\mu V}{^\circ C}$ |
| I <sub>os</sub> Input offset current                                | T <sub>amb</sub> = 25°C  |            | 20         | 200  |            | 3          | 30       |            | 20         | 200  | nA<br>nA                 |
|   | T <sub>amb</sub> = T <sub>min</sub> to T <sub>max</sub>  |            | 85         | 500  |            |            | 70       |            |            | 300  | nA                       |
| $\frac{\Delta I_{os}}{\Delta T}$ Average input offset current drift |  |            |            |      |            |            | 0.5      |            |            |      | $\frac{nA}{^\circ C}$    |
| I <sub>b</sub> Input bias current                                   | T <sub>amb</sub> = 25°C  |            | 80         | 500  |            | 30         | 80       |            | 80         | 500  | nA<br>μA                 |
|   | T <sub>amb</sub> = T <sub>min</sub> to T <sub>max</sub>  |            |            | 1.5  |            |            | 0.21     |            |            | 0.8  | μA                       |
| R <sub>i</sub> Input resistance                                     | T <sub>amb</sub> = 25°C  | 0.3        | 2          |      | 1          | 6          |          | 0.3        | 2          |      | MΩ<br>MΩ                 |
|   | T <sub>amb</sub> = T <sub>min</sub> to T <sub>max</sub>  |            |            |      | 0.5        |            |          |            |            |      | MΩ                       |
| V <sub>i</sub> Input voltage range                                  | T <sub>amb</sub> = T <sub>min</sub> to T <sub>max</sub>  | ±12        | ±13        |      | ±12        | ±13        |          | ±12        | ±13        |      | V                        |
| G <sub>v</sub> Large signal voltage gain                            | T <sub>amb</sub> = 25°C R <sub>L</sub> ≥ 2 kΩ<br>V <sub>s</sub> = ±15V V <sub>o</sub> = ±10V   | 94         | 106        |      | 94         |            |          | 86         | 106        |      | dB                       |
|   | T <sub>amb</sub> = T <sub>min</sub> to T <sub>max</sub><br>R <sub>L</sub> ≥ 2 kΩ<br>V <sub>s</sub> = ±15V V <sub>o</sub> = ±10V<br>V <sub>s</sub> = ±5V V <sub>o</sub> = ±2V | 88         |            |      | 90<br>80   |            |          | 84         |            |      | dB                       |
| V <sub>o</sub> Output voltage swing                                 | V <sub>s</sub> = ±15V<br>R <sub>L</sub> ≥ 10 kΩ<br>R <sub>L</sub> ≥ 2 kΩ   | ±12<br>±10 | ±14<br>±13 |      | ±12<br>±10 | ±14<br>±13 |          | ±12<br>±10 | ±14<br>±13 |      | V<br>V                   |
|   | T <sub>amb</sub> = 25°C<br>T <sub>amb</sub> = T <sub>min</sub> to T <sub>max</sub>   |            | 25         |      | 10<br>10   | 25         | 35<br>40 |            | 25         |      | mA<br>mA                 |
| CMR Common mode rejection   | V <sub>s</sub> = ±20V<br>R <sub>g</sub> ≤ 10 kΩ V <sub>CM</sub> = ±12V   | 70         | 90         |      | 80         | 95         |          | 70         | 90         |      | dB                       |
| SVR Supply voltage rejection  | R <sub>g</sub> ≤ 50Ω V <sub>s</sub> = ±5 to ±20V<br>R <sub>g</sub> ≤ 10kΩ V <sub>s</sub> = ±5 to ±15V  | 77         | 96         |      | 86         | 96         |          | 77         | 96         |      | dB<br>dB                 |



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ELECTRICAL CHARACTERISTICS (continued)

| Parameter   | Test conditions         | LS 141  |          |           | LS 141A |           |            | LS 141C |          |      | Unit         |
|---|-------------------------|---|----------|-----------|---------|-----------|------------|---------|----------|------|--------------|
|   |                         | Min.  | Typ.     | Max.      | Min.    | Typ.      | Max.       | Min.    | Typ.     | Max. |              |
| Transient respon.<br>(unity gain)<br>Rise time<br>Overshoot | $T_{amb} = 25^{\circ}C$ |   | 0.3<br>5 |           |         | 0.25<br>6 | 0.8<br>20  |         | 0.3<br>5 |      | $\mu s$<br>% |
| B   | Bandwidth               |   |          |           | 0.437   | 1.5       |            |         |          |      | MHz          |
| SR  | Slew rate               |   | 0.5      |           | 0.3     | 0.7       |            |         | 0.5      |      | V/ $\mu s$   |
| $I_s$   | Supply current          |   | 1.7      | 2.8       |         |           |            |         | 1.7      | 2.8  | mA           |
| $P_{tot}$   | Power consumption       | $T_{amb} = 25^{\circ}C$<br>$V_s = \pm 20V$<br>$V_s = \pm 15V$ | 50       | 85        |         | 80        | 150        |         | 50       | 85   | mW<br>mW     |
|   |                         | $V_s = \pm 20V$<br>$T_{amb} = T_{min}$<br>$T_{amb} = T_{max}$ |          |           |         |           | 165<br>135 |         |          |      | mW<br>mW     |
|   |                         | $V_s = \pm 15V$<br>$T_{amb} = T_{min}$<br>$T_{amb} = T_{max}$ | 60<br>45 | 100<br>75 |         |           |            |         |          |      | mW<br>mW     |

Note: These specifications, unless otherwise specified, apply for  $V_s = \pm 15V$  and  $T_{amb} = -55$  to  $125^{\circ}C$  for LS 141 and LS 141A. For the LS 141C these specifications apply for  $T_{amb} = 0$  to  $70^{\circ}C$

Fig. 1 - Open loop voltage gain vs. supply voltage

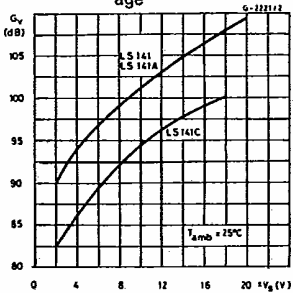


Fig. 2 - Output voltage swing vs. supply voltage

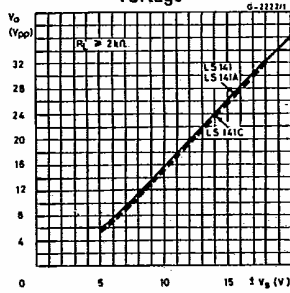


Fig. 3 - Power consumption vs. supply voltage

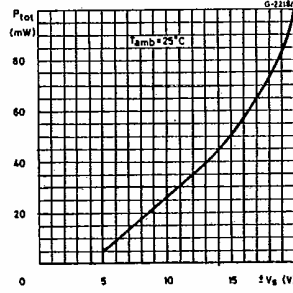


Fig. 4 - Open loop voltage gain vs. frequency

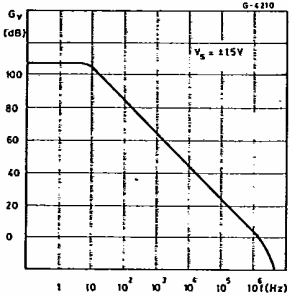


Fig. 5 - Open loop phase response vs. frequency

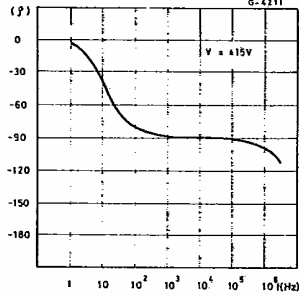


Fig. 6 - Input offset current vs. supply voltage (for LS 141 and LS 141C)

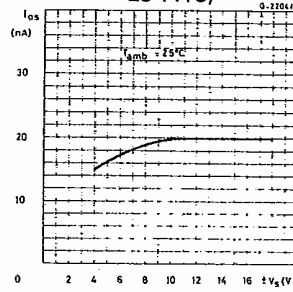


Fig. 7 - Input resistance and capacitance vs. frequency (for LS 141 and LS 141C)

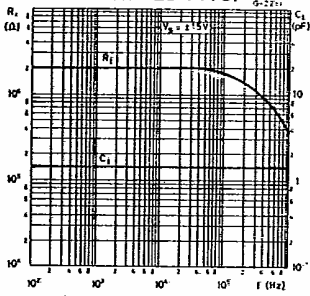


Fig. 8 - Output resistance vs. frequency

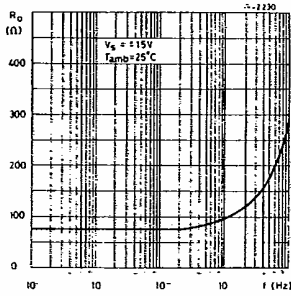


Fig. 9 - Output voltage swing vs. load resistance

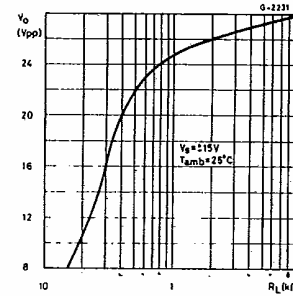


Fig. 10 - Output voltage swing vs. frequency

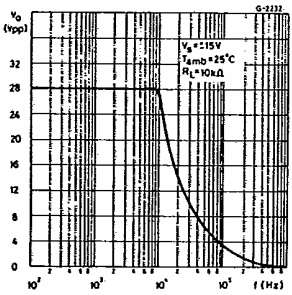


Fig. 11 - Input noise voltage vs. frequency

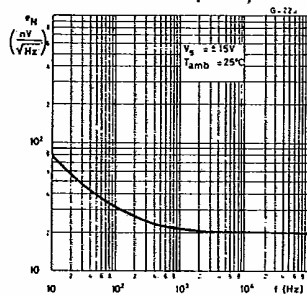


Fig. 12 - Input noise current vs. frequency

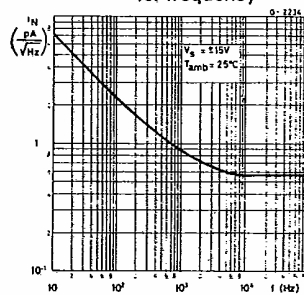


Fig. 13 - Transient response

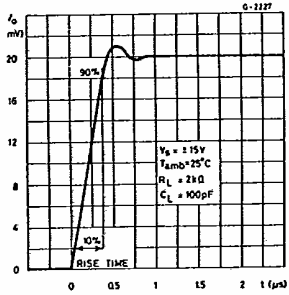


Fig. 14 - Common mode rejection ratio vs. frequency

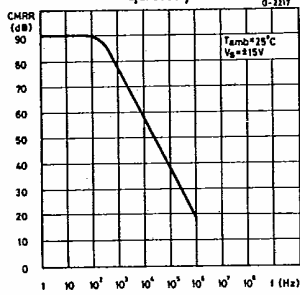
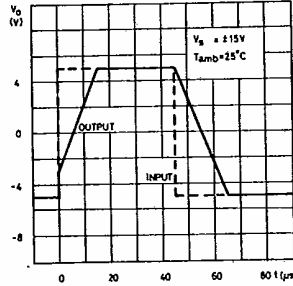


Fig. 15 - Voltage follower large signal pulse response



Typical performance curves for LS 141 and LS 141A

Fig. 16 - Input bias current vs. ambient temperature

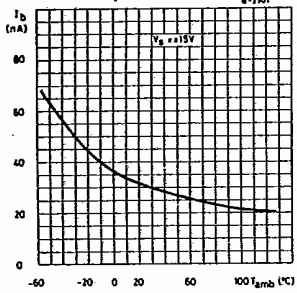


Fig. 17 - Input resistance vs. ambient temperature

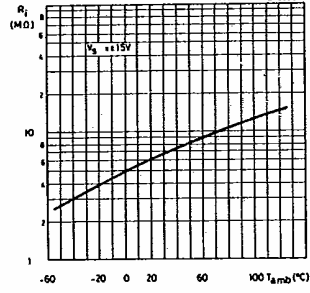


Fig. 18 - Input offset current vs. ambient temperature

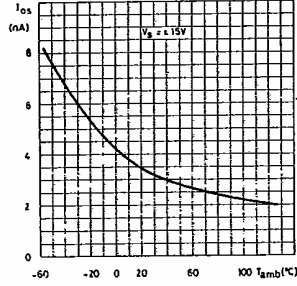


Fig. 19 - Output short-circuit current vs. ambient temperature

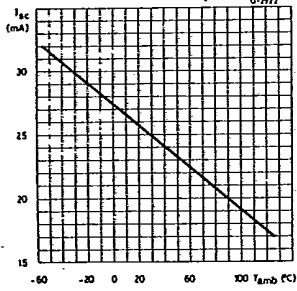


Fig. 20 - Power consumption vs. ambient temperature

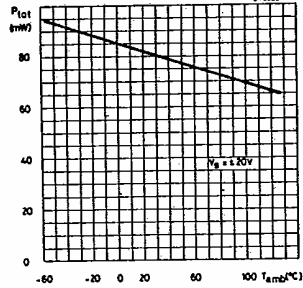
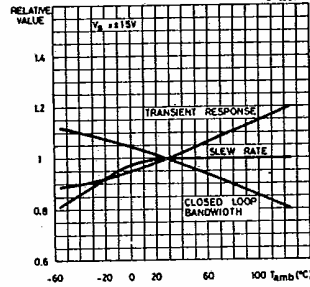


Fig. 21 - Frequency characteristics vs. ambient temperature





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Typical performance curves for LS 141C

Fig. 22 - Input bias current vs. ambient temperature

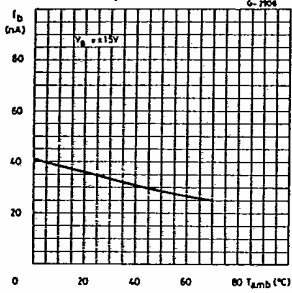


Fig. 23 - Input resistance vs. ambient temperature

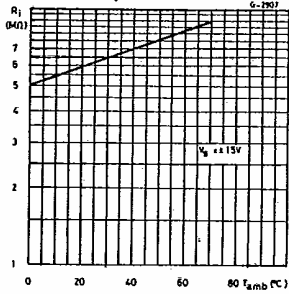


Fig. 24 - Input offset current vs. ambient temperature

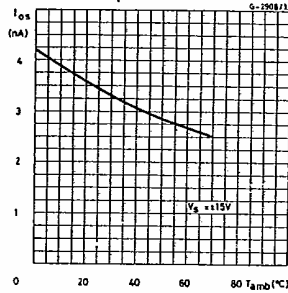


Fig. 25 - Output short circuit current vs. ambient temperature

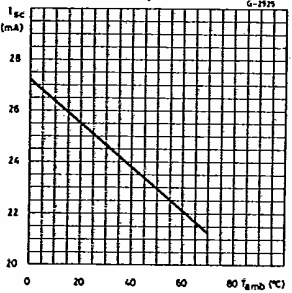


Fig. 26 - Power consumption vs. ambient temperature

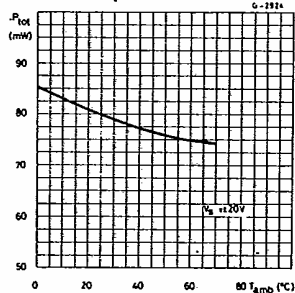
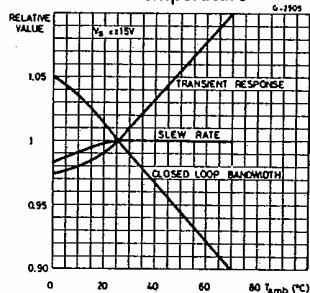


Fig. 27 - Frequency characteristics vs. ambient temperature



TYPICAL APPLICATIONS

Fig. 28 - Clipping amplifier

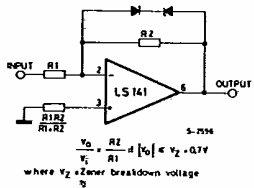


Fig. 29 - Simple integrator

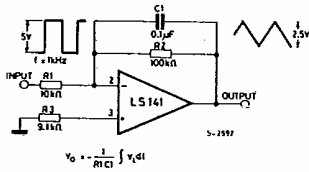
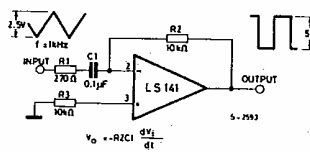


Fig. 30 - Simple differentiator





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